

C₂N/ZnSe heterostructure with type-II band alignment and excellent photocatalytic water splitting performance

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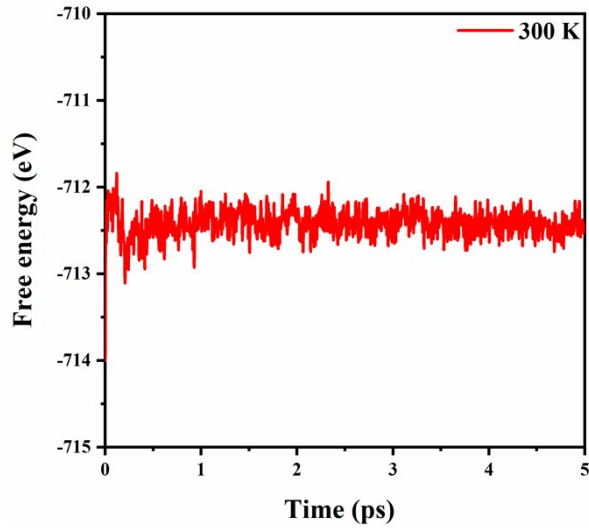


Fig. S1 (a) AIMD fluctuations of the total energy for $C_2N/ZnSe$ heterostructure at 300 K with 5ps. (b)

The top and side views of final structures in AIMD simulation.

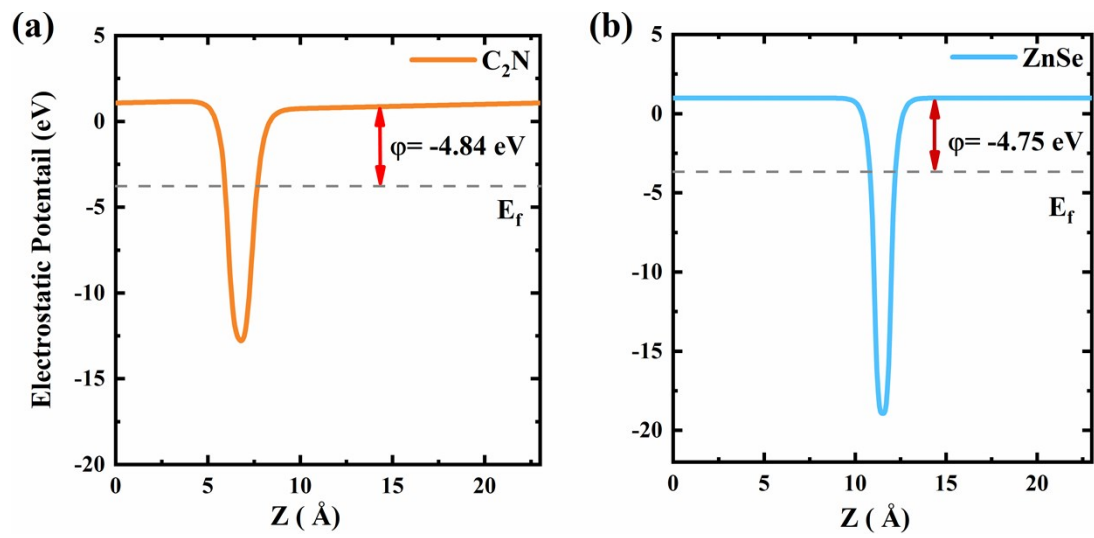


Fig. S2 Electrostatic potential of C_2N and ZnSe monolayer.

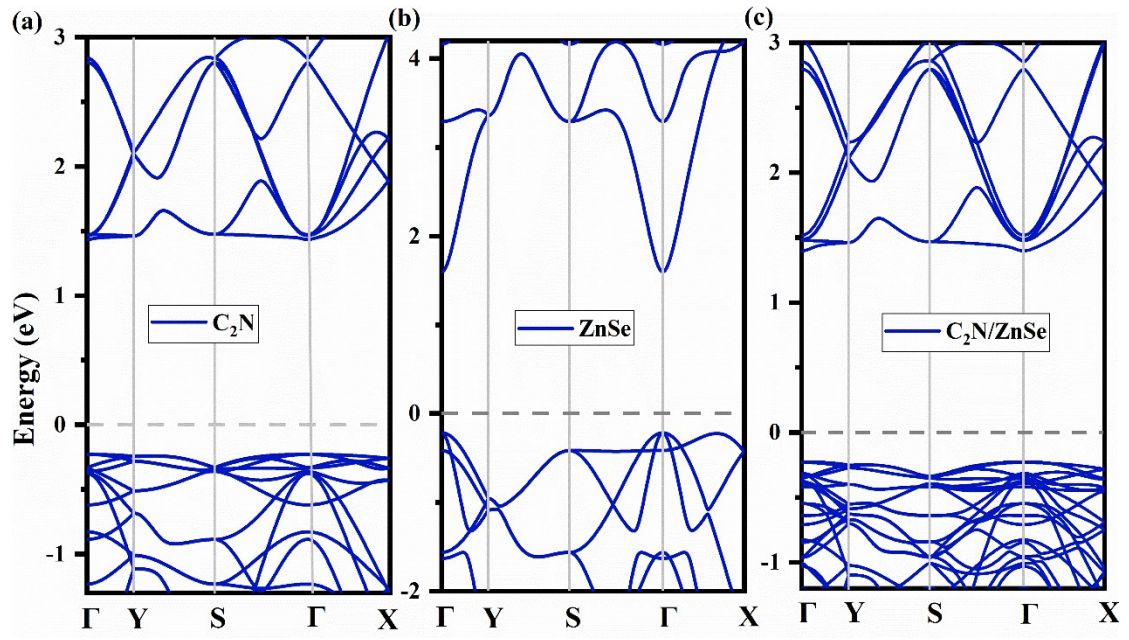


Fig. S3 Electronic band structures of (a) ZnSe monolayer, (b) C_2N monolayer and (c) $C_2N/ZnSe$ heterostructure.

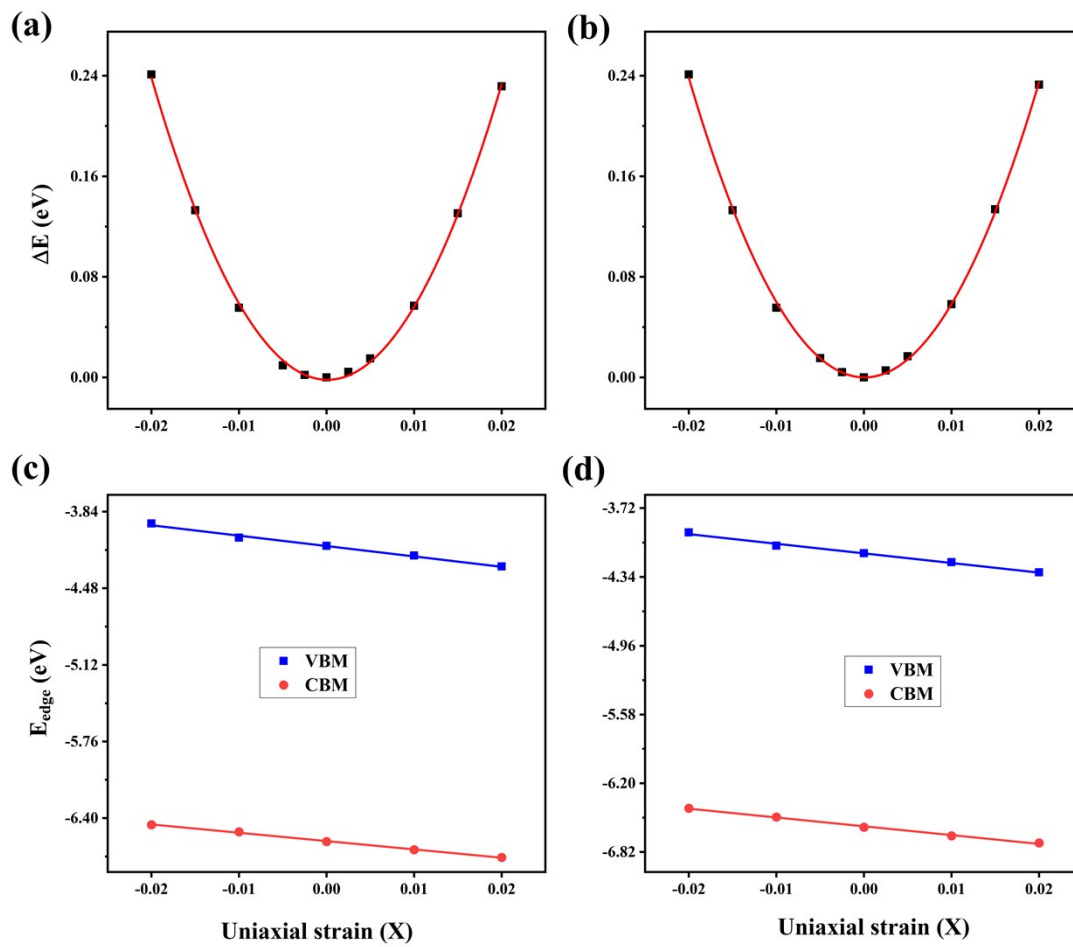


Fig. S4 (a) and (b) Engineering energy difference of monolayer C_2N as function of the uniaxial strain. (c) and (d) Band edge positions of monolayer C_2N as function of uniaxial strain along x and y directions.

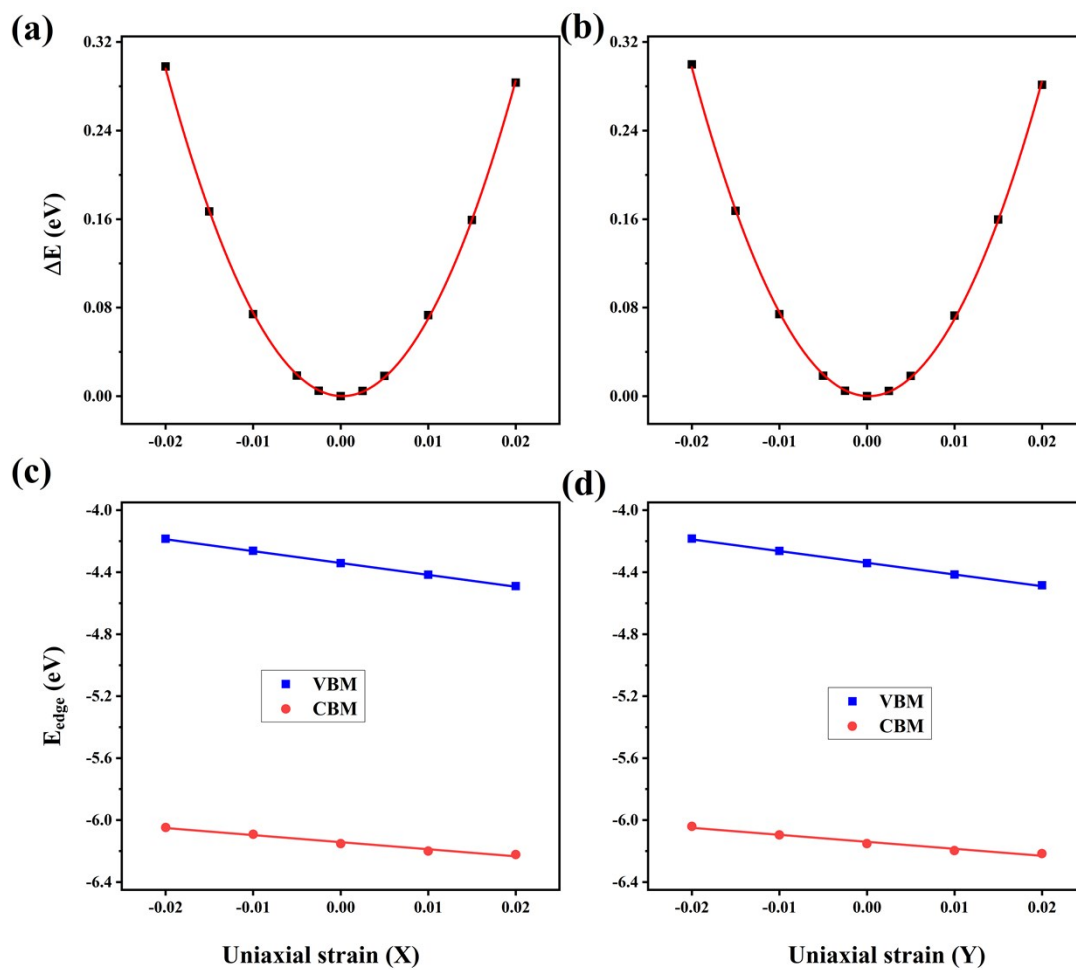


Fig. S5 (a) and (b) Engineering energy difference of monolayer ZnSe as function of the uniaxial strain. (c) and (d) Band edge positions of monolayer ZnSe as function of uniaxial strain along x and y directions.

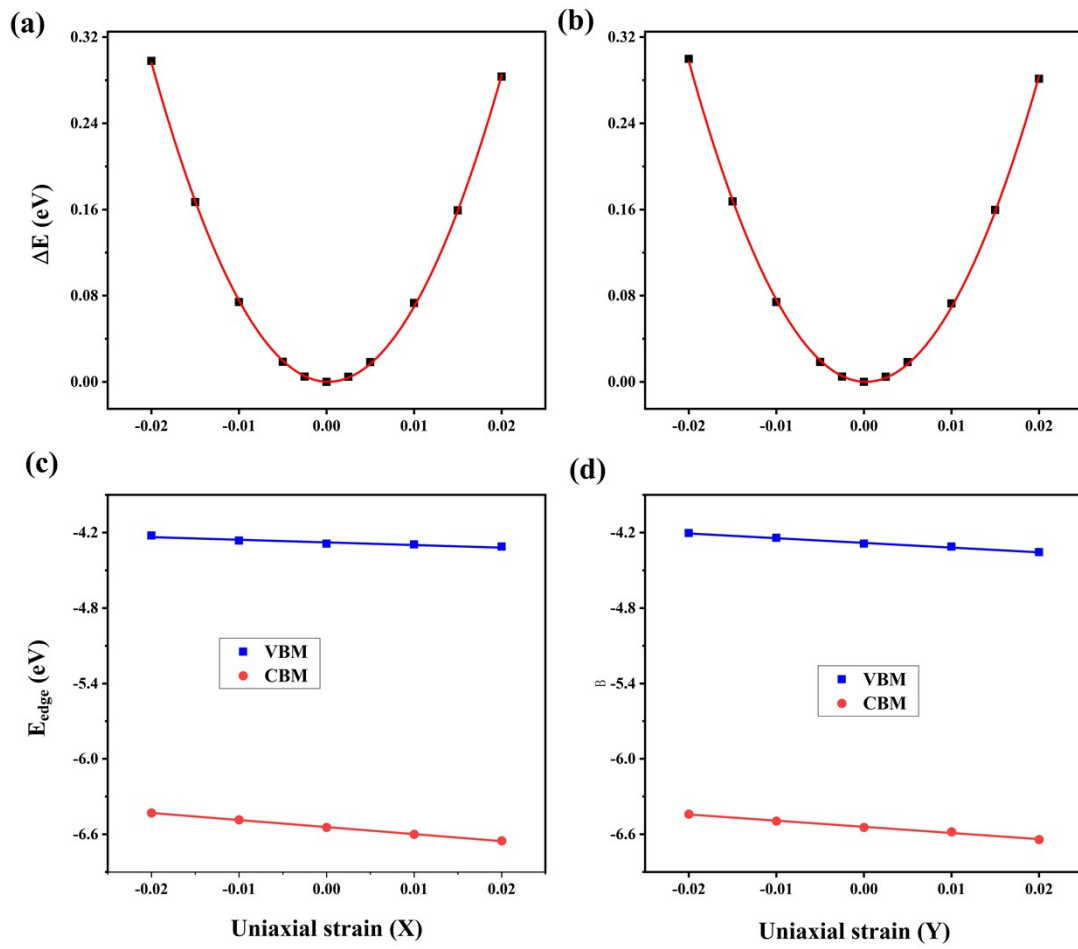


Fig. S6 (a) and (b) Engineering energy difference of monolayer $C_2N/ZnSe$ heterostructure as function of the uniaxial strain. (c) and (d) Band edge positions of monolayer $C_2N/ZnSe$ heterostructure as function of uniaxial strain along x and y directions.